



Advances in Deep Learning II

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Deadline for manuscript submissions:

closed (30 November 2020)

Message from the Guest Editors

The purpose of our Special Issue is to contribute to the demonstration of new algorithms and application domains of deep learning to solve problems in various research areas. Eventually, we are to promote research and development of deep learning for multimodal data, by publishing high-quality research articles and reviews/tutorials in this rapidly growing interdisciplinary field.

Keywords

- deep learning algorithms
- deep reinforcement learning
- deep learning theory
- deep learning architectures
- adversarial examples
- deep generative models
- multitask, transfer, and meta learning
- Bayesian methods
- causal inferences
- explainable and interpretable AI
- representation learning
- constrained optimization
- computer vision
- natural language processing
- application in any other field using deep learning methods





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Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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